

### **Absolute Maximum Rating**

Symbol	Parameter	Max.	Units
$I_D$ @ $T_C$ = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	269①	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	190	^
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited)	240	Α
I <sub>DM</sub>	Pulsed Drain Current ②	990	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	375	W
	Linear Derating Factor	2.5	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
T <sub>J</sub> T <sub>STG</sub>	Operating Junction and Storage Temperature Range	-55 to + 175	°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

#### Avalanche Characteristics

Symbol	Parameter	Max.	Units
E <sub>AS (Thermally limited)</sub>	Single Pulse Avalanche Energy ③	464	m l
E <sub>AS (Thermally limited)</sub>	Single Pulse Avalanche Energy	897	mJ
I <sub>AR</sub>	Avalanche Current ②	Coo Fig 15, 16, 220, 22h	Α
$E_AR$	Repetitive Avalanche Energy ②	See Fig 15, 16, 23a, 23b	mJ

#### **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case ®		0.40	°C/W
$R_{\theta JA}$	Junction-to-Ambient ®		40	

### Static @ $T_J = 25$ °C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	75			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		40		mV/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		1.70	2.00	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 100A
			2.20		mΩ	$V_{GS} = 6.0V, I_D = 50A$
$V_{GS(th)}$	Gate Threshold Voltage	2.1		3.7	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			1.0	μΑ	$V_{DS} = 75 \text{ V}, V_{GS} = 0 \text{V}$
				150		$V_{DS} = 75V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	nA	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-100		V <sub>GS</sub> = -20V
$R_G$	Gate Resistance		1.9		Ω	

#### Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 240A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements. (Refer to AN-1140)
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ Limited by  $T_{Jmax}$ , starting  $T_J = 25$ °C, L =  $93\mu H$ ,  $R_G = 50\Omega$ ,  $I_{AS} = 100A$ ,  $V_{GS} = 10V$ .
- $I_{SD} \le 100A$ , di/dt  $\le 1575A/\mu s$ ,  $V_{DD} \le V_{(BR)DSS}$ ,  $T_J \le 175$ °C.
- ©  $C_{oss}$  eff. (TR) is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- $\odot$  C<sub>oss</sub> eff. (ER) is a fixed capacitance that gives the same energy as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- ®  $R_\theta$  is measured at  $T_J$  approximately 90°C.
- Limited by  $T_{Jmax}$ , starting  $T_J = 25$   $^{\circ}$ C, L = 1mH,  $R_G = 50Ω$ ,  $I_{AS} = 42A$ ,  $V_{GS} = 10V$ .
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.please refer to application note to AN-994: http://www.irf.com/technical-info/appnotes/an-994.pdf



# Dynamic Electrical Characteristics @ $T_J = 25$ °C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	223			S	$V_{DS} = 10V, I_{D} = 100A$
$Q_g$	Total Gate Charge		285	428		I <sub>D</sub> = 100A
$Q_{gs}$	Gate-to-Source Charge		62		nC	V <sub>DS</sub> = 38V
$Q_{gd}$	Gate-to-Drain Charge		86		lic	V <sub>GS</sub> = 10V
Q <sub>sync</sub>	Total Gate Charge Sync. (Qg - Qgd)		199			
$t_{d(on)}$	Turn-On Delay Time		20			$V_{DD} = 38V$
t <sub>r</sub>	Rise Time		90			I <sub>D</sub> = 100A
$t_{d(off)}$	Turn-Off Delay Time		182		ns	$R_G = 2.7\Omega$
t <sub>f</sub>	Fall Time		91			V <sub>GS</sub> = 10V ⑤
C <sub>iss</sub>	Input Capacitance		13970			V <sub>GS</sub> = 0V
$C_{oss}$	Output Capacitance		1135			V <sub>DS</sub> = 25V
$C_{rss}$	Reverse Transfer Capacitance		720		рF	f = 1.0MHz
Coss eff.(ER)	Effective Output Capacitance (Energy Related)		1048			V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V to 60V⑦
Coss eff.(TR)	Output Capacitance (Time Related)		1283			V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V to 60V <sup>®</sup>

## **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)			<b>269</b> ①	_	MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ②			990		integral reverse p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.2	V	$T_J = 25^{\circ}C, I_S = 100A, V_{GS} = 0V$ (§
dv/dt	Peak Diode Recovery dv/dt		11		V/ns	$T_J = 175^{\circ}C, I_S = 100A, V_{DS} = 75V$
t <sub>rr</sub>	Reverse Recovery Time		42 49		ns	$T_J = 25^{\circ}C$ $V_{DD} = 64V$ $T_J = 125^{\circ}C$ $I_F = 100A$ ,
Q <sub>rr</sub>	Reverse Recovery Charge		63		nC	$T_{J} = 25^{\circ}C$ di/dt = 100A/µs $\odot$
≪rr	Treveloe recovery charge		88		1.0	<u>T<sub>J</sub> = 125°C</u>
I <sub>RRM</sub>	Reverse Recovery Current		2.4		Α	T <sub>J</sub> = 25°C



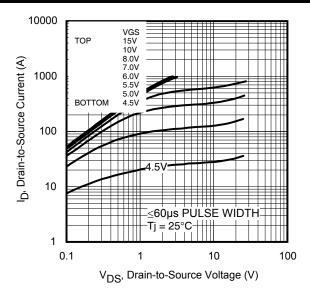


Fig 3. Typical Output Characteristics

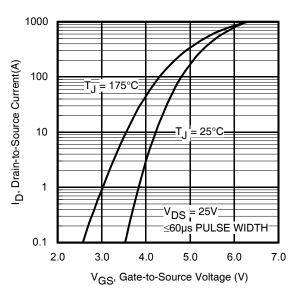
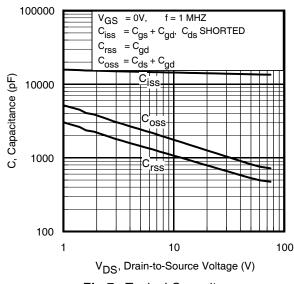


Fig 5. Typical Transfer Characteristics



**Fig 7.** Typical Capacitance vs. Drain-to-Source Voltage

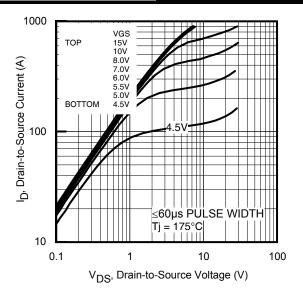


Fig 4. Typical Output Characteristics

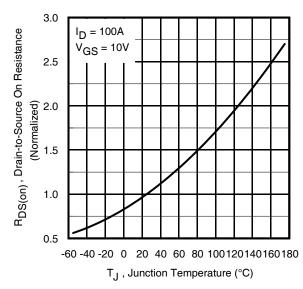
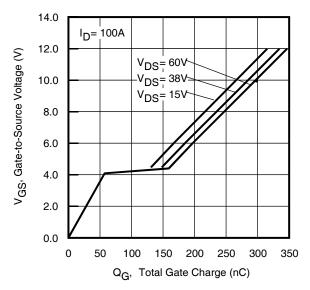


Fig 6. Normalized On-Resistance vs. Temperature



**Fig 8.** Typical Gate Charge vs. Gate-to-Source Voltage



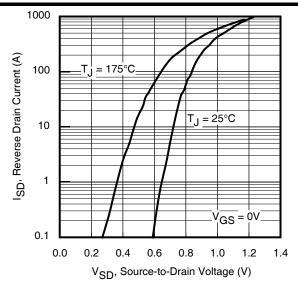


Fig 9. Typical Source-Drain Diode Forward Voltage

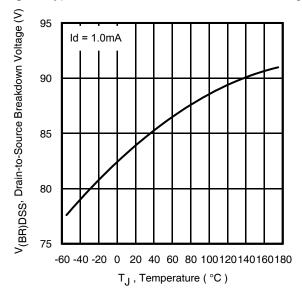


Fig 11. Drain-to-Source Breakdown Voltage

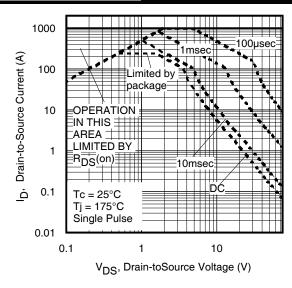


Fig 10. Maximum Safe Operating Area

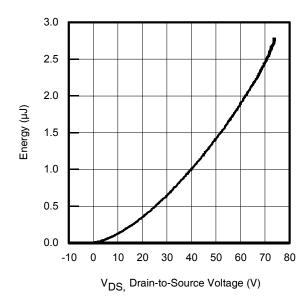


Fig 12. Typical C<sub>oss</sub> Stored Energy

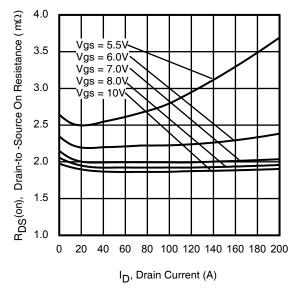


Fig 13. Typical On-Resistance vs. Drain Current



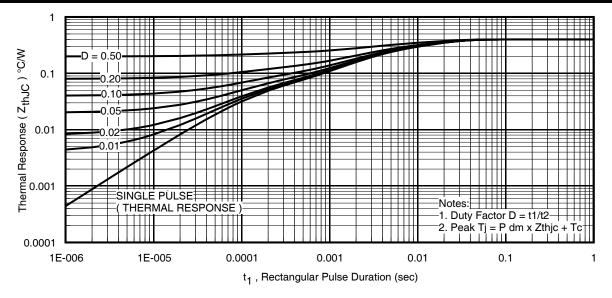


Fig 14. Maximum Effective Transient Thermal Impedance, Junction-to-Case

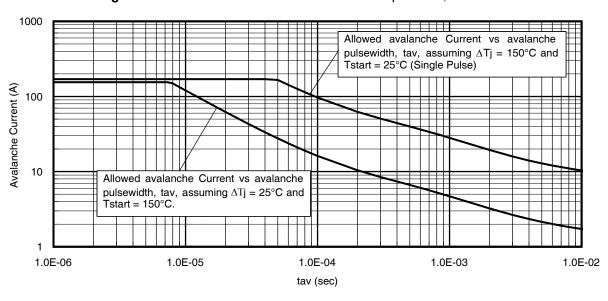


Fig 15. Avalanche Current vs. Pulse Width

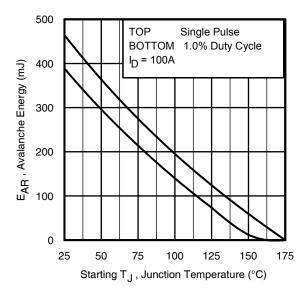


Fig 16. Maximum Avalanche Energy vs. Temperature

### Notes on Repetitive Avalanche Curves , Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

1. Avalanche failures assumption:

Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>imax</sub>. This is validated for every

- 2. Safe operation in Avalanche is allowed as long  $asT_{\textrm{jmax}}$  is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 23a, 23b.
- 4. P<sub>D (ave)</sub> = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{imax}$ (assumed as 25°C in Figure 15, 16).

 $t_{av}$  = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see Figures 13) PD (ave) = 1/2 (  $1.3 \cdot BV \cdot I_{av}$ ) =  $\Delta T / Z_{thJC}$  $I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$ 

 $E_{AS (AR)} = P_{D (ave)} t_{av}$ 



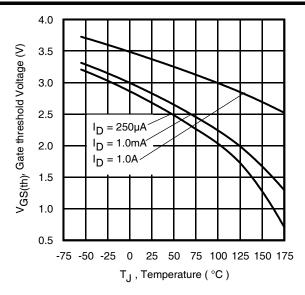


Fig 17. Threshold Voltage vs. Temperature

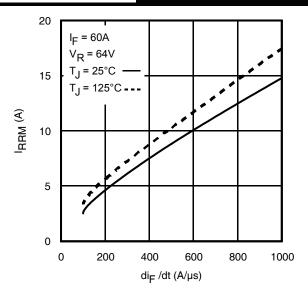


Fig 18. Typical Recovery Current vs. dif/dt

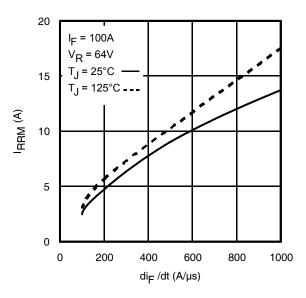


Fig 19. Typical Recovery Current vs. dif/dt

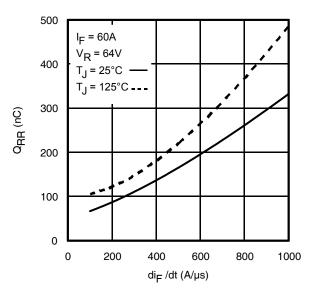


Fig 20. Typical Stored Charge vs. dif/dt

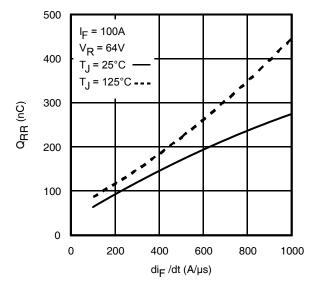


Fig 21. Typical Stored Charge vs. dif/dt



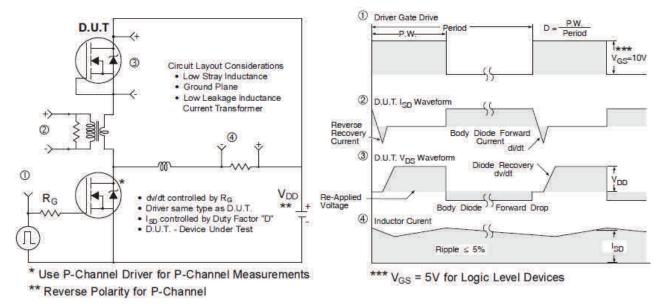


Fig 22. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

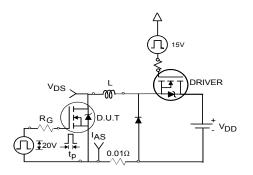


Fig 23a. Unclamped Inductive Test Circuit

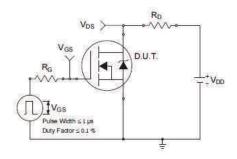


Fig 24a. Switching Time Test Circuit

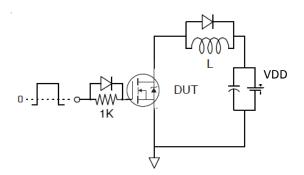


Fig 25a. Gate Charge Test Circuit

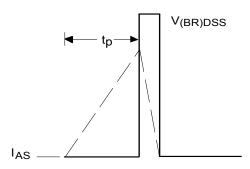


Fig 23b. Unclamped Inductive Waveforms

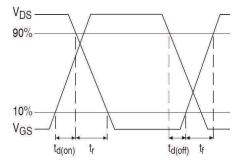


Fig 24b. Switching Time Waveforms

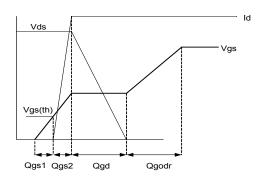
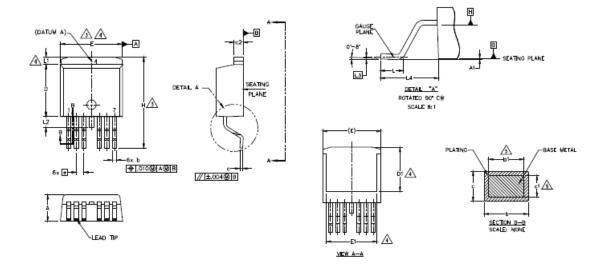


Fig 25b. Gate Charge Waveform



# D<sup>2</sup>Pak-7Pin Package Outline (Dimensions are shown in millimeters (inches))



S Y M B		×			
B	MILLIM	MILLIMETERS INCHES		NOTES	
Ľ	MIN.	MAX.	MIN.	MAX.	S
Α	4.06	4.83	.160	.190	
A1	_	0.254	-	.010	
b	0.51	0.99	.020	.036	
b1	0.51	0.89	.020	.032	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	-	.270		4
E	9.65	10.67	.380	.420	3,4
E1	6.22	_	.245		4
e	1,27	BSC	.050	BSC	
Н	14.61	15.88	,575	.625	
L	1.78	2.79	.070	.110	
L1	-	1.68	-	.066	4
L2	-	1.78	-	.070	
L3	0.25	BSC	.010	BSC	
L4	4.78	5.28	.188	.208	

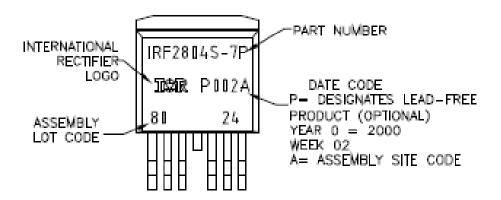
#### NOTES:

- 1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- O.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
  - 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
  - 7, CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263CB.

Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>



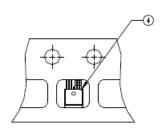
# D<sup>2</sup>Pak-7Pin Part Marking Information



### D2Pak-7Pin Tape and Reel

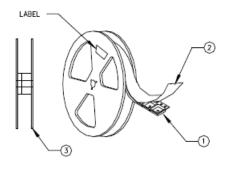
NOTES, TAPE & REEL, LABELLING:

- 1, TAPE AND REEL,
  - 1.1 REEL SIZE 13 INCH DIAMETER.
  - 1.2 EACH REEL CONTAINING 800 DEVICES.
  - 1.3 THERE SHALL BE A MINIMUM OF 42 SEALED POCKETS CONTAINED IN THE LEADER AND A MINIMUM OF 15 SEALED POCKETS IN THE TRAILER.
  - 1.4 PEEL STRENGTH MUST CONFORM TO THE SPEC. NO. 71-9667.
  - 1.5 PART ORIENTATION SHALL BE AS SHOWN BELOW.
  - 1.6 REEL MAY CONTAIN A MAXIMUM OF TWO UNIQUE LOT CODE/DATE CODE COMBINATIONS.
    REWORKED REELS MAY CONTAIN A MAXIMUM OF THREE UNIQUE LOT CODE/DATE CODE COMBINATIONS.
    HOWEVER, THE LOT CODES AND DATE CODES WITH THEIR RESPECTIVE QUANTITIES SHALL APPEAR ON THE BAR CODE LABEL FOR THE APPECTOR DEEL CODE LABEL FOR THE AFFECTED REEL.



- 2. LABELLING (REEL AND SHIPPING BAG).
  - 2.1 CUST. PART NUMBER (BAR CODE): IRFXXXXSTRL-7P
  - 2.2 CUST, PART NUMBER (TEXT CODE): IRFXXXXSTRL-7P
  - 2.3 I.R. PART NUMBER: IRFXXXXSTRL-7P

  - 2.4 QUANTITY: 2.5 VENDOR CODE; IR
  - 2.6 LOT CODE:
  - 2.7 DATE CODE:



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



# Qualification Information<sup>†</sup>

Qualification Level	Industrial (per JEDEC JESD47F) <sup>††</sup>				
Moisture Sensitivity Level	D <sup>2</sup> Pak-7Pin	MSL1			
RoHS Compliant		Yes			

- † Qualification standards can be found at International Rectifier's web site: <a href="http://www.irf.com/product-info/reliability/">http://www.irf.com/product-info/reliability/</a>
- †† Applicable version of JEDEC standard at the time of product release.

### **Revision History**

Date	Comments
11/7/2014	<ul> <li>Updated E<sub>AS (L=1mH)</sub> = 897mJ on page 2</li> <li>Updated note 9 "Limited by T<sub>Jmax</sub>, starting T<sub>J</sub> = 25°C, L = 1mH, R<sub>G</sub> = 50Ω, I<sub>AS</sub> = 42A, V<sub>GS</sub> =10V" on page 2</li> </ul>



**IR WORLD HEADQUARTERS:** 101 N. Sepulveda Blvd., El Segundo, California 90245, USA To contact International Rectifier, please visit <a href="http://www.irf.com/whoto-call/">http://www.irf.com/whoto-call/</a>

#### IMPORTANT NOTICE

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie").

With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

For further information on the product, technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies office (www.infineon.com).

#### WARNINGS

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.